

# **Test Plan Reference**

**PLT** 

0.7.0

2020-04-28

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# **Revision History**

#### **Revision History**

Revision 0.7.0 2020-04-28

• Document calibration: sections

• program, erase: Add PSoC6 and CMSIS targets

• measure: Document unit suffixes, clarify reference argument

Revision 0.6.9 2020-03-30

• Remove ESP32\_HomeKit target

• program: Allow any number of firmware elements

• program: Add PN7360, PN7362, PN7460 and PN7462 targets

• serial set: Set serial number

• pin: Can control SWD\_NRST and UARTx\_RTS

Revision 0.6.8 2020-02-24

New commands:

• canCfg - Configure CAN interface

• canClear - Configure CAN interface

• canMatch - Match received CAN message

• canSend - Send CAN message

• ftdiCfg - Configure external FTDI

Revision 0.6.5 2019-10-07

• Add STM32F2 and ST32F2\_STLink targets

Revision 0.6.4 2019-10-08

No change

Revision 0.6.3 2019-10-07

• document `noflush` option for uart and uartExpect commands

• eval command

• uart: extract multiple keys

ble test: Low-level BLE testing

Revision 0.6.2 2019-10-03

• document JLink/ST-Link target variants • update initial example scan: ANY format • serial request: user key extraction Revision 0.5.7 2019-08-22 • `label` command: Document ZPL templates • add Nordic nRF91 Cortex-M33 targets Revision 0.5.6 2019-08-19 • Document retry mechanism for test items and test item steps • Document GATT-level BLE commands • Document 'image' command test step to set background images • Document setting Label substitutions with the `label` command test step • add AVRATmega168P/PB targets Revision 0.5.2 2019-05-13 • `measure`: Document `reference` argument • Document `nfc` command Revision 0.5.1 2019-04-16 • Add `CC1352` target • Document 'define' command Revision 0.5.0 2019-03-31 • Document `freq` command • Document 'measure' command • Document `mux` command • Document 'pin' command • Document 'power' command • Document `short` command • Document `uartCfg` command Revision 0.4.9 2019-03-28 • Document `serial request` command

• Update UART port names

Revision 0.4.8 2019-03-08

Renamed to Test Plan Reference

Revision 0.4.7 2019-03-08

Split off from System Manual

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# **Preface**

Document describing the test suite definition for use with the Production Line Tool.

# 1. Test Plan Reference

# 1.1 Test Plan YAML definition

Example: A minimal test suite, with a single test item, scanning a bar code.

title: "PLT demo: Scan"

suite:

- ident: SCAN-T1

title: Scan MAC address

steps:

- command: scan ANY

#### 1.1.1 Test Plan Structure

PLT test suites are encoded as YAML text files, starting with the test suite title.

title: "PLT demo: Scan"

The title: is followed by the suite: section, containing the test items in the test plan.

#### 1.1.1.1 Test Items

Test items are identified with an **ident**: line, can contain a descriptive **title**, and should contain one or more test item steps.

The ident: field can be omitted, in which case test items will be automatically enumerated. A top-level identPrefix: field can be used to set common prefix for auto-generated test item identifiers.

During test execution, all test item steps need to complete successfully for the test item to succeed.

#### 1.1.1.2 Test Item Steps

Test item steps consist of command: or uartcmd: blocks. A Test Item can contain multiple Test Item steps.

#### **1.1.1.3 Retries**

Retry counts can be set for at the test item or at the test item step level, by adding a retry: field.

title: "Retries" identPrefix: "R"

suite:

- title: Test Item retries

retry: 3 steps:

command: sleepms 1000command: operator Manual

title: Test Item retries

steps

- command: sleepms 1000

- command: operator Manual

retry: 3

## 1.1.2 Basic Example

A basic In-Circuit Test suite for the PLT demo board.

```
title: "v0.1.8 (Green)"
identPrefix: "ICT"
suite:
- title: Identify DUT
    steps:
    - command: identify nRF52
- title: Erase nRF52
    steps:
    - command: erase nRF52
- title: Program DEMO-BOARD FW nRF52
    steps:
    - command: program nRF52 s132_nrf52_6.0.0_softdevice.hex,ly10-demo-fw-0.1.8.hex
- title: BLE discovery
    steps:
    - command: bledis %BLEMAC% 30 # Wait up to 30 seconds for BLE discovery to complete
```

#### 1.1.3 Calibration

Some test setups may require additional calibration, which can be specified in the YAML test plan with an optional top-level calibration: section.

```
calibration:
- [ppc: <ppcID>]
  [impedance: <impedanceOffset>]
  [voltage: <voltageOffset>]
  [voltageDATP07: <voltageOffset>]
  [voltageDATP08: <voltageOffset>]
  [voltageDATP09: <voltageOffset>]
  [voltageDATP10: <voltageOffset>]
  [voltageDATP11: <voltageOffset>]
  [voltageDATP12: <voltageOffset>]
  [voltageMUX0: <voltageOffset>]
  [voltageMUX1: <voltageOffset>]
  [voltageMUX2: <voltageOffset>]
  [voltageMUX3: <voltageOffset>]
  [current: <currentOffset>]
  [current3V3: <current0ffset>]
  [current5V: <current0ffset>]
  [currentVARV: <currentOffset>]
```

The following fields can be set in a calibration entry:

Field	Description
ppc:	Define the PPC for which this calibration entry should be applied. If omitted, the section defines the default offsets, to which a PPC-specific calibration section would be added.
impedance:	Specifies the offset for impedance measurements.
voltage:	Specifies the offset for voltage measurements.
voltageDATP07:	Specifies the offset for voltage measurements on the voltageDATP07 measurement channel.  Overrides the offset specified in the voltage: field.
voltageDATP08:	Specifies the offset for voltage measurements on the voltageDATP08 measurement channel.  Overrides the offset specified in the voltage: field.
voltageDATP09:	Specifies the offset for voltage measurements on the voltageDATP09 measurement channel.  Overrides the offset specified in the voltage: field.
voltageDATP10:	Specifies the offset for voltage measurements on the voltageDATP10 measurement channel.  Overrides the offset specified in the voltage: field.
voltageDATP11:	Specifies the offset for voltage measurements on the <b>voltageDATP11</b> measurement channel. Overrides the offset specified in the <b>voltage:</b> field.
voltageDATP12:	Specifies the offset for voltage measurements on the voltageDATP12 measurement channel.  Overrides the offset specified in the voltage: field.

Field	Description
voltageMUX0:	Specifies the offset for voltage measurements on the voltageDATP09 measurement channel.  Overrides the offset specified in the voltage: field.
voltageMUX1:	Specifies the offset for voltage measurements on the <b>voltageDATP10</b> measurement channel. Overrides the offset specified in the <b>voltage:</b> field.
voltageMUX2:	Specifies the offset for voltage measurements on the <b>voltageDATP11</b> measurement channel. Overrides the offset specified in the <b>voltage:</b> field.
voltageMUX3:	Specifies the offset for voltage measurements of the <b>voltageDATP12</b> measurement channel. Overrides the offset specified in the <b>voltage:</b> field.
current:	Specifies the offset for current measurements.
current3V3:	Specifies the offset for current measurements of the current3V3 measurement channel. Overrides the offset specified in the current: field.
current5V:	Specifies the offset for current measurements of the current5V measurement channel. Overrides the offset specified in the current: field.
currentVARV:	Specifies the offset for current measurements of the currentVARV measurement channel.  Overrides the offset specified in the current: field.

With the following argument values:

Argument	Description
	PPC identifier for a ppc: field, to define a calibration specific to a particular PPC.
impedanceOffset	Offset for impedance measurements. Can be specified with n0hm, u0hm/µ0hm, m0hm, 0hm, k0hm/K0hm or M0hm suffixes. If no suffix is specified, the offset is assumed to be specified in 0hm.
Ιναιτοαρί Ιπτορτ	Offset for voltage measurements. Can be specified with $nV$ , $uV/\mu V$ , $mV$ , $V$ , $kV/KV$ or $MV$ suffixes. If no suffix is specified, the offset is assumed to be specified in Volt.
Ι Ο Ι ΙΤΡΩΝΤΙ ΙΤΤΟΩΤ	Offset for current measurements. Can be specified with $nA$ , $uA/\mu A$ , $mA$ or $A$ suffixes. If no suffix is specified, the offset is assumed to be specified in Ampere.

## Example:

title: "test plan with calibration" identPrefix: "ICT-T"

calibration: # Default offsets

- impedance: -100 # 100 Ohm

voltage: +20mV # Default for all voltage channels

voltageDATP01: +40mV voltageMUX2: +20mV voltageMUX3: +30mV currentVARV: -20mA

# Additional offsets specific to a particular PPC ppc: 39c8db # Additional offsets for this PPC

impedance: +1200hm voltageDATP08: -10mV current5V: +100mA

suite:

- title: Impedance Measurement

steps:

- command: mux 0 RATP02 - command: mux 1 RATP17 - command: mux 2 RA - command: mux 3 RVREF - command: short 0 2 set

- command: short 1 3 set

- command: measure impedance 10-200hm

# 1.2 Test Commands

## 1.2.1 ble gatt - GATT-level BLE Tests

Perform GATT-level BLE interactions with the DUT.

## Usage:

```
ble gatt connect addr:<address> [<timeout> [<minRSSI>]]
ble gatt connect name:<name> [<timeout> [<minRSSI>]]
ble gatt disconnect
ble gatt discover
ble gatt match char:<charUUID> <matchHex>
ble gatt read char:<charUUID> <matchHex>
ble gatt sub char:<charUUID>
ble gatt write char:<charUUID> <valueHex>
```

Argument	Description
name	GAP name advertised by DUT.
address	BLE MAC address used by the DUT.
timeout	Timeout, in seconds
minRSSI	RSSI treshold (optional)
connect	Connect to GATT peripheral
disconnect	Disconnect from GATT peripheral
discover	Discover GATT services and characteristics
match	Match a value for a subscribed characteristic
read	Read a GATT characteristic
sub	Subscribe to notifications from a GATT characteristic
write	Write to a GATT characteristic

Example: Validate BLE Device Information Service

```
title: "DIS Validation"
suite:
- ident: ICT-T1
  title: Identify DUT
  steps:

    command: identify nRF52

- ident: ICT-T2
  title: Program LY10-DEMO-BOARD FW
  steps:
  - command: program nRF52 s132_nrf52_6.0.0_softdevice.hex,ly10-demo-fw-0.1.7.hex
 ident: ICT-T3
  title: Validate BLE DIS
  steps:
  - command: ble gatt connect addr: %ble_mac% 10
  - command: ble gatt discover
 # GAP: Device Name
  - command: ble gatt read char: 2a00 4c5931302d44454d4f5f424f415244 # "LY10-DEMO BOARD"
 # GAP Appearance
  - command: ble gatt read char:2a01 0000
 # GAP:Peripheral Preferred Connection Parameters
  - command: ble gatt read char: 2a04 0600080200009001
 # GAP:Central Address Resolution
  - command: ble gatt read char:2aa6 01
 # DIS:Manufacturer Name String
  - command: ble gatt read char:2a29 424344 # "BCD"
 # DIS:Model Number String
  - command: ble gatt read char:2a24 4c5931302d44454d4f5f424f415244 # "LY10-DEMO_BOARD"
 # DIS:Hardware Revision String
  - command: ble gatt read char:2a27 32303139 # "2019"
 # DIS:Firmware Revision String
  - command: ble gatt read char:2a26 302e312e37 # "0.1.7"
 # DIS:Software Revision String
  - command: ble gatt read char:2a28 312e322e33 # "1.2.3"
  - command: ble gatt disconnect
```

#### 1.2.2 ble test - Low-level BLE Tests

Perform Low-level BLE tests.

Usage:

```
ble test recv <channel>
ble test xmit <channel> [<length> [<payload>]]
ble test stop
```

Argument	Description
channel	BLE channel
length	Test packet payload length
payload	Test packet payload type

## 1.2.3 bledis - Test BLE Discovery

Establishes a BLE connection to the DUT and discovers GATT services.

Usage:

#### bledis %BLEMAC%|<name> [<timeout> [<minRSSI>]]

Argument	Description
name	GAP name advertised by DUT. <b>%BLEMAC</b> % to specify the DUT's BLE MAC address instead
timeout	Timeout, in seconds
minRSSI	RSSI treshold (optional)

Example: BLE discovery of identified BLE HW MAC address.

- ident: ICT-T1

title: Identify DUT

steps:

- command: identify nRF52

- ident: ICT-T2

title: BLE Discovery

steps:

- command: bledis %BLEMAC% 30 -60

## 1.2.4 canCfg - Configure CAN interface

Configure the PLT CAN interface speed.

Usage:

## canCfg <port> <bitrate>

Argument	Description
port	PLT CAN interface; currently only <b>CAN0</b> is available.
bitrate	CAN bit rate, in bits per second.

## 1.2.5 canClear - Configure CAN interface

Clear the buffer of received CAN frames.

Usage:

## canClear <port>

Argument	Description
port	PLT CAN interface; currently only CANO is available.

## 1.2.6 canMatch - Match received CAN message

Test if a particular CAN message has been received.

Usage:

## canMatch <port> <msgId> [<b> <b> ...]

Argument	Description
port	PLT CAN interface; currently only <b>CAN0</b> is available.
msgld	CAN Message Arbitration ID
b	Payload bytes

## 1.2.7 canSend - Send CAN message

Send a CAN data frame.

Usage:

## canSend <port> <msgId> [<b <b>...]

Argument	Description
port	PLT CAN interface; currently only <b>CAN0</b> is available.
msgld	CAN Message Arbitration ID
b	Payload bytes

## 1.2.8 define - Define user key

Manually defines a test plan key, which will be emedded in the test report and serial number requests performed as part of the current test plan.

Usage:

## define <key> <value>

Argument	Description
key	Name of the test plan key.
value	Value for the key; can be any kind of string value.

- ident: ICT-T0

title: Set variables

steps:

- command: define work\_order 1011X02

- ident: ICT-T1

title: Request serial

steps:

- command: request serial

## 1.2.9 erase - Erase DUT Flash

Erase DUT MCU on-board flash.

Usage:

- command: erase <target> [UART0|UART1]

- command: erase CMSIS
 pack: <cmsis\_pack>
 target: <cmsis\_target>

Argument	Description
target	Target to erase
UARTO, UART1	Port for UART targets
cmsis_pack	For <b>cmsis</b> target: CMSIS Pack file
cmsis_target	For cmsis target: Target name, as defined in CMSIS Pack file

## Supported target values:

target	Description	
AVRATmega168P_ISP	Atmel AVR ATmega168P(A) (JTAG:ISP)	
AVRATmega168P_XPm	Atmel AVR ATmega168P(A) (USB, XPmini)	
AVRATmega168PB_ISP	Atmel AVR ATmega168PB (JTAG:ISP)	
AVRATmega168PB_XPm	n Atmel AVR ATmega168PB (USB, XPmini)	
CC1352	TI CC1352 RFSoC	
CMSIS	CMSIS-DAP programmer, requires $pack:$ and $target:$ fields (USB)	
DA14580	Dialog DA14580 RFSoC	
ESP32	Espressif ESP32 RFSoC (JTAG)	
ESP32_JTAG	Espressif ESP32 RFSoC (JTAG)	
ESP32_UART	Espressif ESP32 RFSoC (UART)	
LPC11xx	NXP LPC11xx MCU (SWD)	
nRF52	Nordic nRF52 RFSoC (SWD)	

target	Description	
nRF52_JLink	Nordic nRF52 RFSoC (USB, JLink)	
nRF91	Nordic nRF9160 RFSoC:Cortex-M33 (SWD)	
nRF91_JLink	Nordic nRF9160 RFSoC:Cortex-M33 (USB, JLink)	
STM32F2	ST STM32F2xx MCU (SWD)	
STM32F2_STLink	ST STM32F2xx MCU (USB, ST-Link)	
STM32F4	ST STM32F4xx MCU (SWD)	
STM32F4_STLink	ST STM32F4xx MCU (USB, ST-Link)	
STM32L4	ST STM32L4xx MCU (SWD)	
STM32L4_STLink	ST STM32L4xx MCU (USB, ST-Link)	

Example: Erase STM32L4 on-board flash.

- ident: ICT-T1 title: Erase

steps:

- command: erase STM32L4

# 1.2.10 eval - Evaluate Expression

Evaluate an expression.

## eval <expression>

Argument	Description
expression	Expression to evaluate

## Supported operators:

Operator	Description	
+	Addition, concatenation	
-	Subtraction, Negation	
/	Division	
*	Multiplication	
**	Power	
%	Modulo	
&	Bitwise And	
	Bitwise Or	
^	Bitwise Xor	
?	Bitwise Not	
^	Right shift	
<b>~</b>	Left shift	
!	Inversion	
&&	Logical And	
	Logical Or	
?	Ternary True	
:	Ternary False	
??	Null coalescence	
>	Greater than	
<=	Less than or equal	

Operator	Description	
>=	Greater than or equal	
=~	Regex match	
!~	Regex mismatch	

## Example:

```
title: "Eval"
suite:
- ident: E0
  title: Eval
  steps:
- command: define test "AC1D"
- command: eval "test != 'F00BAR'" # PASS
- command: eval "test = 'AC1D'" # PASS
- command: eval "test != 'AC1D'" # FAIL
```

## 1.2.11 extflash\_write - Write Peripheral Flash

Write DUT periperal flash.

Usage:

extflash\_write UART0|UART1 <filename>

Argument	Description
UARTO, UART1	Port for UART targets
filename	Firmware Element Filename

## 1.2.12 freq - Frequency Monitor Control

Set the channel to use for frequency measurements.

Usage:

## freq 0|1

Argument	Description
0	Use CLK0
1	Use CLK1

Example: Measure CLK1 frequency

title: Measure frequency

suite:

- ident: ICT-T1

title: Measure CLK1 frequency

steps:

- command: freq 1

- command: sleepms 1000

- command: measure frequency 7.90-8.10MHz

## 1.2.13 ftdiCfg - Configure external FTDI

Configure an externally connected FTDI FT4232H module.

Usage:

ftdiCfg FTDI1 <target> [<UARTxx>][,<UARTxx>[,<UARTxx>]]]

Argument	Description	
target	FTDI interface; only FTDI1 can be configured.	
UARTxx	UART port to use for each FTDI port: UART2, UART3,, or $\_$ to skip.	

# 1.2.14 identify - Identify DUT

Identify DUT MCU and/or RF peripherals.

Usage:

## identify <target> [UART0|UART1]

Argument	Description
target	Target to identify
UARTO, UART1	Port for UART targets

Supported *target* values:

target	Description
AVRATmega168P_ISP	Atmel AVR ATmega168P(A) (JTAG:ISP)
AVRATmega168P_XPm	Atmel AVR ATmega168P(A) (USB, XPmini)
AVRATmega168PB_ISP	Atmel AVR ATmega168PB (JTAG:ISP)
AVRATmega168PB_XPm	Atmel AVR ATmega168PB (USB, XPmini)
CC1352	TI CC1352 RFSoC
DA14580	Dialog DA14580 RFSoC
ESP32	Espressif ESP32 RFSoC (JTAG)
ESP32_JTAG	Espressif ESP32 RFSoC (JTAG)
ESP32_UART	Espressif ESP32 RFSoC (UART)
nRF52	Nordic nRF52 RFSoC (SWD)
nRF52_JLink	Nordic nRF52 RFSoC (USB, JLink)
nRF91	Nordic nRF9160 RFSoC:Cortex-M33 (SWD)
nRF91_JLink	Nordic nRF9160 RFSoC:Cortex-M33 (USB, JLink)
STM32F2	ST STM32F2xx MCU (SWD)
STM32F2_STLink	ST STM32F2xx MCU (USB, ST-Link)
STM32F4	ST STM32F4xx MCU (SWD)
STM32F4_STLink	ST STM32F4xx MCU (USB, ST-Link)
STM32L4	ST STM32L4xx MCU (SWD)
STM32L4_STLink	ST STM32L4xx MCU (USB, ST-Link)

# 1.2.15 image - Set background image

Usage:

image set <filename>

image clear

Argument	Description	
set	Set background image	
clear	Clear background image	
filename	Filename of the PNG or JPEG element to show	

Example: Background for operator test

```
title: "OLED Image"
suite:
- ident: ICT-T1
  title: Show image
  steps:
- command: image set fighter.png
- command: operator "Manual test"
```

#### 1.2.16 label - Set Label Substitutions

Usage:

```
label keys <key> [<key>...]
```

The label command defines additional keys to substitute in the ZPL sent to the barcode printer, in addition to the default substitution keys.

Key	Description
DUT_PRODUCT	Product name
DUT_VERSION	Version
DUT_SERIAL	DUT Serial number
MAC_ADDRESS	MAC address
BLEMAC	BLE MAC address
FAILURE_MSG	Test failure

Example: Substitute CODE

```
title: "Custom barcode substitution"
suite:
- ident: ICT-T0
   title: Define label keys
   steps:
- command: define CODE 12345
- command: label keys CODE
```

The default ZPL generated by the PLT upon completion of a YAML test plan specification can be overridden by uploading template-pass.zpl and template-fail.zpl elements as part of the Release deployed through PLTcloud.

```
^FX template-fail.zpl - ZPL Template for failing DUTs
^XA^LH40,30
^MD2
^F00,10^ADN,30,8^FDC0DE^FS
^F00,80^ADN,30,8^FDN/G^FS
^FX template-pass.zpl - ZPL Template for DUTs that pass testing
^{\text{XA}}
~SD22
^CF0,30
^F040, 20^FDProduct:DUT_PRODUCT^FS
^F040,30^FDVersion:DUT_VERSION^FS
^F040,40^FDS/N:DUT_SERIAL^FS
^F040,50^FDMAC Address:MAC_ADDRESS^FS
^F040,60^FDBLE Address:BLEMAC^FS
^F040,70^FDFailure:FAILURE_MSG^FS
^F040,80^FDCode:CODE^FS
^F040,170^BY2
^BCN, 50, N, N, N
^FDMAC ADDRESS^FS
```

#### 1.2.17 measure - Probe Measurement

# measure <channel> [<signal>] <range> [<reference>]

Argument	Description
channel	Measurement channel
signal	DDTPxx or RDTPxx probe for <b>pin</b> measurement
range	Acceptable range
reference	Reference voltage for impedance measurements (default: 5V)

The **measure** command supports the following channels:

channel	Description
current3V3	3V3 current draw
current5V	5V current draw
currentVARV	VARV current draw
frequency	Frequency (CLK0 or CLK1)
impedance	Impedance measurement (RVREF/RA)
pin	Digital pin measurement (DDTPxx/RDTPxx)
voltageDATP07	DATP07 voltage
voltageDATP08	DATP08 voltage
voltageDATP09	DATP09 voltage
voltageDATP10	DATP10 voltage
voltageDATP11	DATP11 voltage
voltageDATP12	DATP12 voltage
voltageMUX0	MUX0 voltage
voltageMUX1	MUX1 voltage
voltageMUX2	MUX2 voltage
voltageMUX3	MUX3 voltage

The following suffixes are supported for electrical measurement ranges:

Kind	Suffix	Description
Frequency	Hz	Hertz (default)
Frequency	kHz, KHZ	Kilohertz
Frequency	MHZ	Megahertz
Frequency	GHz	Gigahertz
Voltage	nV	Nanovolt
Voltage	uV, μV	Microvolt
Voltage	mV	Millivolt
Voltage	V	Volt (default)
Voltage	kV, KV	Kilovolt
Voltage	MV	Megavolt
Current	nA	Nanoampere
Current	uΑ, μΑ	Microampere
Current	mA	Milliampere
Current	А	Ampere (default)
Impedance	n0hm	Nanoohm

Kind	Suffix	Description
Impedance	u0hm, µ0hm	Microohm
Impedance	mOhm	Milliohm
Impedance	Ohm	Ohm (default)
Impedance	kOhm, KOhm	Kiloohm
Impedance	MOhm	Megaohm

Example: Electrical measurements

```
title: Electrical measurements
suite:
- ident: ICT-T1
  title: Measure CLKO frequency
  steps:
   command: freq 0
  - command: sleepms 1000
  - command: measure frequency 32.75-32.78kHz
 ident: ICT-T2
  title: Measure Impedance
  steps:
  - command: mux 0 RATP02
  - command: mux 1 RATP18
  - command: mux 2 RA
  - command: mux 3 RVREF
  - command: short 0 2 set
  - command: short 1 3 set
  - command: measure impedance 750-1000m0hm 3.3V
  - command: short 0 2 release
  - command: short 1 3 release
  - command: sleepms 1500
  - command: measure impedance 2-100hm 3300
 ident: ICT-T3
  title: Measure Currents
  steps:
  - command: measure current3V3 <1A
  - command: measure current5V 0.1-0.5A
  - command: measure currentVARV >100mA
 ident: ICT-T4
  title: Measure Voltages
  steps:
  - command: mux 0 DATP00
  - command: mux 1 DATP01
  - command: mux 2 RATP00
  - command: mux 3 RATP17
  - command: measure voltageMUX0 >1V
  - command: measure voltageMUX1 <3300mV
  - command: measure voltageMUX2 >100mV

    command: measure voltageMUX3 1500-1800mV

  - command: measure voltageDATP07 200-6000mV
  - command: measure voltageDATP08 -0.2-0.1V
  - command: measure voltageDATP09 0-4V
  - command: measure voltageDATP10 -0.1-3.3V
  - command: measure voltageDATP11 0-3.4V
  - command: measure voltageDATP12 -0.1-3.4V
```

Example: Digital pin measurement

title: Digital pin measurements suite:

- ident: ICT-T1

title: Configure Digital pins as inputs

steps:

- command: pin RDTP21 input pullup

- command: pin DDTP04 input

- ident: ICT-T2

title: Read Digital pins

steps:

- command: measure pin RDTP21 low - command: measure pin DDTP04 high

## 1.2.18 mux - Multiplex Control

Select a probe or signal for a multiplex channel.

Usage:

## mux <channel> <signal>

Argument	Description
channel	Multiplex channel (03)
signal	Probe or signal

The following signals and probes can be assigned to a multiplex channel:

signal	MUX	Description
DATP00DATP06	0, 1	Direct Analog Test Probes
RATP00RATP31	0, 1	Routed Analog Test Probes
DDTP00DDTP08	2,3	Direct Digital Test Probes
RVREF	all	Impedance measurement, reference voltage
RA	all	Impedance measurement, test voltage
GND	all	Ground
3V30UT	all	3.3V power rail
5V0UT	all	5.0V power rail
VARVDIV	all	VARV power rail, after 1/3 voltage divider

Example: Multiplex control

title: Multiplex control example

suite:

- ident: ICT-T1
 title: Setup MUX

steps:

command: mux 0 DATP02
command: mux 1 DATP03
command: mux 2 RA
command: mux 3 RVREF
command: short 0 2 set
command: short 1 3 set

- ident: ICT-T2

title: Measure impedance DATP02..DATP03

steps:

- command: measure impedance 10-200kOhm

## 1.2.19 nfc - NFC Handling

Manipulate NFC cards.

Usage:

nfc write <TAGTYPE> <payload>...

Argument	Description
tagtype	Tag type (NTAG203, NTAG213 or NTAG216)
payload	NDEF payload (text:)

Example: Program NDEF message with two text records.

- ident: ICT-T1
 title: Write NFC

steps:

- command: define CODE 123

- command: nfc write NTAG213 text:"Sample Text" text:%CODE%

## 1.2.20 operator - Operator Test

Instruct operator to perform a manual test step.

Usage:

## operator <message>

Example: Instruct operator to inspect housing.

- ident: ICT-T1

title: Visual Inspection (manual)

steps:

- command: operator "Inspect Housing"

## 1.2.21 pin - Digital pin control

Configure a Digital probe.

Usage:

pin probe> input [pullup]
pin probe> output [low|high]

Argument	Description
probe	Probe (DDTPxx, RDTPxx, UARTx_RTS or SWD_NRST)
input	Configure as input
pullup	Enable pull-up (only for RDTPxx pins)
output	Configure as output
low	Set low
high	Set high

Example: Control digital pins

```
title: Control digital pins
suite:
- ident: ICT-T1
 title: Configure digital inputs
 steps:
  - command: pin DDTP05 input
  - command: pin DDTP03 input
  - command: pin RDTP04 input pullup
- ident: ICT-T2
 title: Control digital outputs
 steps:
  - command: pin DDTP00 output high
  - command: pin DDTP02 output low
  - command: pin RDTP01 output high
  - command: pin SWD_NRST output low
  - command: pin UART1_RTS output high
```

## 1.2.22 power - Power Control

Control power applied to the Device Under Test.

Usage:

power off
power <rail> [on|off|<level>]

Argument	Description
rail	Power rail
on	Turn on the specified power rail
off	Turn off all or specified power rail
level	Voltage level for <b>VARV</b> : 212.0

Supported rail values:

rail	Description
3V3	3.3V power rail
5V	5V power rail
VARV	Variable power rail
12V	12V power rail
SWD	SWD (3.3V) power rail
JTAG	JTAG (3.3V) power rail
UART0	UARTO (3.3V) power rail
UART1	UART1 (3.3V) power rail

Example: Apply power

title: Power control example

suite:

ident: ICT-T1 title: Apply power

steps:

command: power 3V3 oncommand: power 5V oncommand: power VARV 10.2

- ident: ICT-T2 title: Wait steps:

- command: sleepms 1000

- ident: ICT-T3
 title: Power off

steps:

- command: power off

## 1.2.23 program - Program DUT

Erase and Program DUT MCU on-board flash.

Usage:

- command: program <target> [UART0|UART1] [offset:]<img>[,[offset:]<img>[,...]] [noerase]

- command: program CMSIS [offset:]<img>

pack: <cmsis\_pack>
target: <cmsis\_target>

Argument	Description
target	Target to program
UARTO, UART1	Port for UART targets
offset	Optional: Offset image
img	Firmware Element
	Optional: Additional offsets, images
cmsis_pack	For <b>cmsis</b> target: CMSIS Pack file
cmsis_target	For <b>cmsis</b> target: Target name, as defined in CMSIS Pack file

Firmware images can be provided as Intel HEX (.hex), ELF (.elf / .axf) or binary files (requiring an offset).

Supported target values:

target	Description
AVRATmega168P_ISP	Atmel AVR ATmega168P(A) (JTAG:ISP)
AVRATmega168P_XPm	Atmel AVR ATmega168P(A) (USB, XPmini)
AVRATmega168PB_ISP	Atmel AVR ATmega168PB (JTAG:ISP)
AVRATmega168PB_XPm	Atmel AVR ATmega168PB (USB, XPmini)
CC1352	TI CC1352 RFSoC
CMSIS	CMSIS-DAP programmer, requires pack: and target: fields (USB)
DA14580	Dialog DA14580 RFSoC
ESP32	Espressif ESP32 RFSoC (JTAG)
ESP32_JTAG	Espressif ESP32 RFSoC (JTAG)
ESP32_UART	Espressif ESP32 RFSoC (UART)
LPC11xx	NXP LPC11xx MCU (SWD)
nRF52	Nordic nRF52 RFSoC (SWD)

target	Description
nRF52_JLink	Nordic nRF52 RFSoC (USB, JLink)
nRF91	Nordic nRF9160 RFSoC:Cortex-M33 (SWD)
nRF91_JLink	Nordic nRF9160 RFSoC:Cortex-M33 (USB, JLink)
PN7360	NXP PN7360 (SWD)
PN7362	NXP PN7362 (SWD)
PN7460	NXP PN7460 (SWD)
PN7462	NXP PN7462 (SWD)
PSoC6	Cypress PSoC6 (SWD)
PSoC6_KP3	Cypress PSoC6 (USB, KitProg3)
STM32F2	ST STM32F2xx MCU (SWD)
STM32F2_STLink	ST STM32F2xx MCU (USB, ST-Link)
STM32F4	ST STM32F4xx MCU (SWD)
STM32F4_STLink	ST STM32F4xx MCU (USB, ST-Link)
STM32L4	ST STM32L4xx MCU (SWD)
STM32L4_STLink	ST STM32L4xx MCU (USB, ST-Link)

Example: Program NXP LPC11C24 over SWD, using built-in PLT programmer.

title: "NXP LPC11C24 (SWD)"

identPrefix: ICT-

suite:

- title: Power via SWD\_VDD

steps:

- command: power SWD on - title: Program firmware

steps:

- command: program lpc11xx blinky.hex

Example: Program NXP LPC11C24 over a USB-attached CMSIS-DAP programmer, using the Keil **Keil.LPC1100\_DFP.1.4.0.pack** CMSIS Pack file.

title: "NXP LPC11C24 (CMSIS-DAP)"

identPrefix: ICT-

suite:

- title: Power via 3V3

steps:

command: power 3V3 ontitle: Program firmware

steps:

 command: program cmsis blinky.hex pack: Keil.LPC1100\_DFP.1.4.0.pack

target: LPC11C24FBD48/301

## 1.2.24 scan - Scan Barcode

Scan a barcode using USB-attached barcode scanner.

Usage:

#### scan <format>

Argument	Description
format	Format of code to scan

Supported *format* values:

format	Description
ANY	Any barcode
%MAC_ADDRESS%	48-bit MAC address (XX:XX:XX:XX:XX)

```
title: Scan serial number
suite:
- steps:
- command: scan ANY
    extractKey: MY_BARCODE
- command: serial set %MY_BARCODE%
```

## 1.2.25 serial - Request or set serial number

Set serial number, from test plan or through PLTcloud.

Under Project Settings in PLTcloud, serial number allocation can be configured to use either monotonic counters, or through a webhook.

Usage:

```
serial request [<KEY>:<jsonKey>]...
serial set <value>
```

Argument	Description
request	Request serial number through PLTcloud backend
KEY	Test plan user key to extract from webhook response
jsonKey	Webhook response "extra" map key
set	Request serial number through PLTcloud backend

When using serial request, and a webhook is selected in PLTcloud, a JSON request will be sent containing:

```
{
   "dut_id": "<DUT IDENTIFIER>",
   "serial_number": "<SERIAL NUMBER>",
   "ble_mac": "<BLE MAC>",
   "mcu_id": "<MCU ID>",
   "MYCUSTOMKEY": "my custom value"
}
```

The API endpoint should return something like:

```
{
    "serial_number": "<SERIAL NUMBER>",
    "extra": {
        "name": "Ben"
    }
}
```

To extract the name field, use the serial request command as below:

title: Eventbrite
suite:

- ident: SCAN title: Scan steps:

- command: scan ANY

extractKey: BARCODE

- ident: WEBHOOK

title: Lookup barcode

steps:

- command: serial request NAME:name

- command: operator %NAME%

ident: PRINT title: Print badge

steps:

- command: label keys NAME

Using serial set, the serial number can be set directly from the test plan, for example using a key extracted from a barcode scan:

title: Scan serial number

suite: - steps:

> command: scan ANY extractKey: BARCODE

- command: serial set %BARCODE%

## 1.2.26 short - Connect Multiplex channels

Usage:

short <muxA> <muxB> set|release

Argument	Description
muxA	Multiplex channel (03)
тихВ	Multiplex channel (03)
set	Short specified multiplex channels
release	Release short between specified multiplex channels

Example: connect multiplex channels

title: Multiplex example

suite:

- ident: ICT-T1

title: Control shorts

steps:

command: short 0 1 setcommand: short 1 3 setcommand: sleepms 1000

· ident: ICT-T1

title: 0-2 instead of 0-1

steps:

- command: short 0 1 release - command: short 0 2 set

## 1.2.27 sleepms - Delay

Temporarily suspend test suite execution.

Usage:

sleepms <duration>

Argument	Description
----------	-------------

Argument	Description
duration	Duration, in milliseconds

## 1.2.28 uart - Send and Extract UART response

Extract data from UART.

Usage:

uartcmd: uart UART0|UART1 [noflush]

[[expect: <expectText>] [extract: <extractText>

extractKey: <extractKey>...]]

[send: <sendText>]

Argument	Description
UARTO, UART1	UART port
expectText	Text to expect, prior to extraction
extractText	Regular expression to extract
extractKey	Key(s) in which to store extracted text
sendText	Text to send prior to extaction
noflush	Don't flush receive buffer before extraction

Example: extract ICCID from cellular modem, storing in the ICCID key.

- uartcmd: uart UART0

expect: "+CCID:"

extract: "CCID: (\\d{20})\r\n"

extractKey: ICCID send: "AT+ICCID\r\n"

## 1.2.29 uartAwait - Await UART response

Wait for a specific UART response.

Usage:

uartAwait UART0|UART1 <seconds>

Argument	Description
UARTO, UART1	UART port
seconds	Time to await response, in seconds

#### Example:

- command: uartExpect UARTO Pressed - command: operator "Press button"

- command: uartAwait UART0 1

## 1.2.30 uartCfg - Configure UART

Configure a UART port.

Usage:

uartCfg UART0|UART1 <speed> [<triplet>] uartCfg UARTO tp

Argument	Description
----------	-------------

Argument	Description
UARTO, UART1	UART port
speed	Baud rate
triplet	UART configuration triplet: 8N1 or 7E1
tp	Use alternate test points instead of UART. (Only for UART0)

## Example:

- command: uartCfg UART1 9600 8N1 - command: uartCfg UART0 tp

## 1.2.31 uartExpect - Set expectation for uartAwait

Set a UART response to wait for with the uartAwait command.

Usage:

## uartExpect UART0|UART1 <expect> [noflush]

Argument	Description
UARTO, UART1	UART port
expect	String to expect with subsequent uartAwait command
noflush	Don't flush receive buffer before extraction

## Example:

command: uartExpect UARTO Pressedcommand: operator "Press button"command: uartAwait UARTO 1

## 1.2.32 uartReadTimeout - Test if UART is not transmitting

Test if nothing is received from UART.

Usage:

## uartReadTimeout UART0|UART1 <seconds> [<sendText>]

Argument	Description
UARTO, UART1	UART port
seconds	Number of seconds to wait for incoming data
sendText	Text to send before waiting

Example: Test if modem is shut down.

- command: uartReadTimeout UART0 1 "AT"